## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | LIN ET AL. | Examiner | Art Unit | H. Jey Tsai | 2812 | Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0140016	10-2002	Cha, Seon Yong	257/302
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